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MAS6282 IC FOR 6.50 – 40.00 MHz VCTCXO

- Min. Supply Voltage 2.6 V
- Max. Frequency 40 MHz
- True Sine Wave Output
- Frequency Stability ±2.0 ppm
- Suitable for Ultra Small VCTCXO
- Very Low Phase Noise

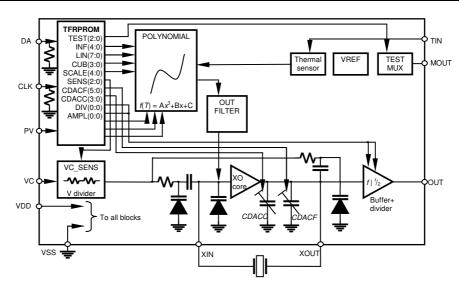
DESCRIPTION

The MAS6282 is an integrated circuit well suited to build VCTCXO for mobile communication. Temperature calibration is achieved in three calibration temperatures only. The trimming is done through a serial bus and the calibration information is stored in an internal PROM. This means no rework for trimming is needed. To build a VCTCXO only a crystal is required in addition to MAS6282. The compensation method is fully analog, working continuously without generating any steps or other interference. Output is true sine wave resulting in lower harmonics than with clipped sine wave output.

FEATURES

- Very small size
- Minimum Vdd 2.6V
- No voltage reference capacitor needed
- Programmable VC-sensitivity
- Divider option selectable by a PROM bit
- Output peak voltage (amplitude) option selectable by a PROM bit

BLOCK DIAGRAM



APPLICATIONS

- VCTCXO for mobile phones
- VCTCXO for other applications



PIN DESCRIPTION

| Pin Description MAS6282A | Symbol | x-coordinate | y-coordinate |
|-----------------------------------|--------|--------------|--------------|
| Crystal/Varactor Oscillator Input | XIN | 185 | 1229 |
| Power Supply Voltage | VDD | 436 | 1229 |
| Serial Bus Data Input | DA | 1071 | 1229 |
| Serial Bus Clock Input | CLK | 1342 | 1229 |
| Buffer Output | OUT | 1612 | 1229 |
| Voltage Control Input | VC | 209 | 152 |
| Crystal Oscillator Output | XOUT | 477 | 152 |
| Temperature Output | TIN | 780 | 152 |
| Programming Input | PV | 1071 | 152 |
| Test Multiplexer Output | MOUT | 1335 | 152 |
| Power Supply Ground | VSS | 1612 | 152 |

Note: Because the substrate of the die is internally connected to GND, the die has to be connected to GND or left floating. Please make sure that GND is the first pad to be bonded. Pick-and-place and all component assembly are recommended to be performed in ESD protected area.

Note: Pad coordinates are measured from the left bottom corner of the chip to the center of the pads. The coordinates may vary depending on sawing width and location, however, distances between pads are accurate. **Note:** Test Multiplexer Output is for testing only and must not be connected in module.

ABSOLUTE MAXIMUM RATINGS

| Parameter | Symbol | Min | Max | Unit | Note |
|-----------------------|-------------------|----------------------|-----------------------|------|------|
| Supply Voltage | $V_{DD} - V_{SS}$ | -0.3 | 5.5 | V | |
| Input Voltage | V _{IN} | V _{SS} -0.3 | V _{DD} + 0.3 | V | 1) |
| Power Dissipation | P _{MAX} | | 20 | mW | 2) |
| Storage Temperature | T _{ST} | -55 | 150 | °C | |
| ESD Rating; HBM | | ±2 | | kV | 3) |
| Latchup Current Limit | I _{LUT} | ±100 | | mA | |

Note: Stresses beyond the values listed may cause a permanent damage to the device. The device may not operate under these conditions, but it will not be destroyed

Note 1: Not valid for programming pin PV

Note 2: Value depends on a thermal resistance of the used packade

Note 3: In pins XIN and XOUT maximum ESD rating is 1 kV.



RECOMMENDED OPERATION CONDITIONS

| Parameter | Symbol | Conditions | Min | Тур | Max | Unit | Note |
|-----------------------------|-----------------|-------------------------------------|-----|-----|-----|--------|------|
| Supply voltage | V _{DD} | | 2.6 | 2.8 | 4.0 | V | |
| Supply current | I _{CC} | Vdd = 2.8 V, f _c =26 MHz | | 1.3 | | mA | |
| Supply current | I _{CC} | $Vdd = 2.8 V, f_c = 40 MHz$ | | 1.5 | | mA | |
| Operating temperature | T _{OP} | | -40 | | +85 | °C | |
| Crystal load capacitance | CL | | | 8 | | pF | 1) |
| Crystal pulling sensitivity | S | | 18 | | 30 | ppm/pF | |
| Crystal Rs | R _S | | | 20 | 50 | Ω | |
| | | | | | | | |

Note 1: CDACF = 32 and CDACC = 8

ELECTRICAL CHARACTERISTICS

| Parameter | | Symbol | Min | Тур | Max | Unit | Note |
|--------------------------------|--------------|--------------------|-------|---------|------------|----------------------------------|------|
| Crystal frequency range | for MAS6282 | f _c | 13.00 | | 40.00 | MHz | 1) |
| Voltage control range | | V _C | 0 | 1.3 | VDD | V | |
| Voltage control sensitivit | ty (SENS=7) | V _{CSENS} | | 10 | | ppm/V | 2) |
| Frequency vs. supply vo | ltage | dfo | | | ±0.2 | ppm | 3) |
| Frequency vs. load char | ige | dfo | | | ±0.2 | ppm | 4) |
| Output voltage (10 kΩ | 10 pF) | V _{out} | 0.6 | 0.8/1.0 | | Vpp | 5) |
| Power Consumption | | Р | | | 8 | mW | 8) |
| Harmonic distortion | | | | -25 | | dBc | |
| Compensation range ±2.0 ppm | | T _C | -30 | | 85 | °C | |
| Compensation range linear part | | a1 | -0.7 | | 0.0 | ppm/K | |
| Compensation inflection point | | INF | 20.5 | | 36 | °C | |
| Compensation range cu | bic part | a3 | | 95 | | ppm ² /K ³ | |
| Fine compensation CDA | CF (6 Bit) | C _{XOUT} | C10 | | C10 + 0.95 | pF | 6) |
| Coarse compensation C | DACC (4 Bit) | C _{XOUT} | C20 | | C20 + 6.75 | pF | 6) |
| Start-up time | | T _{START} | | 2 | | ms | |
| | @ 10Hz | φ _n | | | -90 | dBc/Hz | |
| | @ 100Hz | | | | -113 | | |
| Phase noise | @ 1kHz | | | | -136 | | 7) |
| | @ 10kHz | | | | -148 | | |
| | @ 100kHz | | | | -155 | | |

Note 1: Frequency division by two is selected by PROM bit DIV: 0=no division, 1=div by 2 Thus IC output frequency range is 6.5 MHz – 40 MHz.

Note 2: Depending on crystal pulling

Note 3: VDD±5%

Note 4: R=10 kΩ±10%, C=10 pF±10%

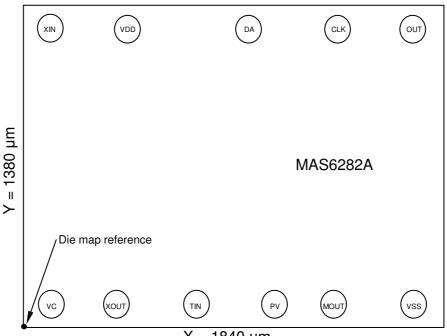
Note 5: 0.8 V / 1.0 V output is selected by PROM bit AMPL: 0=0.8 Vpp, 1=1.0Vpp

Note 6: Typically C10 = 3.1 pF at CDACF=0, CDACC=0

Note 7: Not measured in production testing; guaranteed by design

Note 8: Max power consumption is 8 mW when V_{DD} is 4V





X = 1840 µm

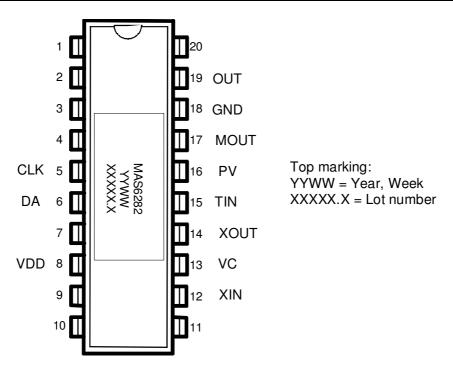
Note 1: MAS6282 pads are round with 80 μ m diameter at opening.

Note 2: Pins CLK and DA can either be connected to VSS or left floating, pin PV can either be connected to VSS or left floating and pin TIN must be left floating in VCTCXO module end-user application.

Note 3: Die map reference is the actual left bottom corner of the sawn chip.

Note 4: See coordinates in pin description on page 2.

SAMPLES IN SBDIL 20 PACKAGE





ORDERING INFORMATION

| Product Code | Product | Package | Comments |
|---------------|----------------------------------|-------------------------------|---------------------------|
| MAS6282A1TG00 | IC for 6.5MHz to 40MHz VCTCXO | EWS Tested wafers 215 μm | Die Size 1.840 x 1.380 mm |

Contact Micro Analog Systems Oy for other wafer thickness options.

The formation of product code

| Product name | Design version | Package type | Delivery format | |
|--------------|----------------|------------------------------------|-----------------|--|
| MAS6282 | A1 | TG = 215 µm thick EWS tested wafer | 00 = bare wafer | |

LOCAL DISTRIBUTOR

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